1.6X0.8mm SMD CHIP LED LAMP

Part Number: APT1608SEC/J4-AMT

Super Bright Orange

Features

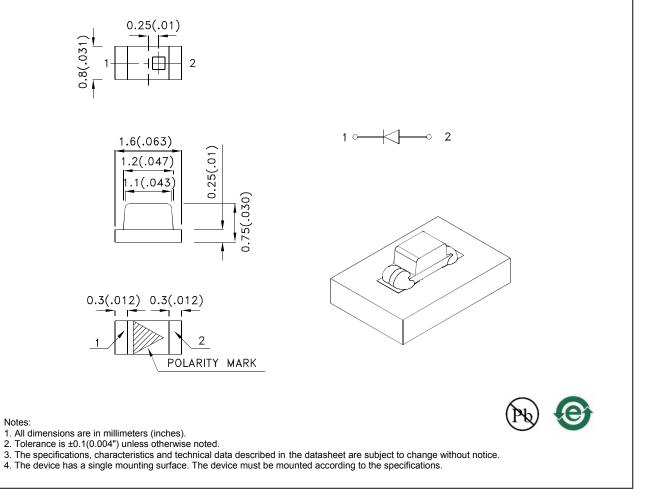
- High reliability LED package.
- 1.6mmx0.8mm SMT LED,0.75mm thickness
- Low power consumption.
- Wide viewing angle.
- Ideal for backlight and indicator.
- Package: 2000pcs / reel .
- Moisture sensitivity level : level 3.
- RoHS compliant.

Description

The Orange source color devices are made with AlGaInP Light Emitting Diode.

Applications

- Traffic signaling.
- Backlighting (illuminated advertising , general lighting).
- Interior and exterior automotive lighting.
- Substitution of micro incandescent lamps.
- Reading lamps.
- Signal and symbol luminaire for orientation.
- Marker lights (e.g. Steps, exit ways, etc).
- Decorative and entertainment lighting.
- Indoor and outdoor commercial and residential architectural lighting.



SPEC NO: DSAL3995 APPROVED: WYNEC

REV NO: V.2A CHECKED: Allen Liu DATE: JAN/23/2015 DRAWN: Q.M.Chen PAGE: 1 OF 6 ERP: 1203012228

Package Dimensions

Part No.	Dice	Lens Type	lv (mcd) [2] @ 20mA			Viewing Angle [1]
			Code.	Min.	Max.	201/2
APT1608SEC/J4-AMT	Super Bright Orange (AlGaInP)	Water Clear	W	1600	1900	120°
			х	1900	2300	
			Y	2300	2700	
			Z	2700	3100	
			*R	*400	*500	
			*S	*500	*700	
			*T	*700	*1000	
			*U	*1000	*1300	

Notes: 1.01/2 is the angle from optical centerline where the luminous intensity is 1/2 of the optical peak value.

2.Luminous intensity/ luminous Flux: +/-15%. *Luminous intensity value is traceable to the CIE127-2007 compliant national standards.

Absolute Maximum Ratings at Ta=25°C

Parameter	Symbol	Value	Unit	
Power dissipation	PD	84	mW	
Reverse Voltage	VR	5	V	
Junction temperature	TJ	115	°C	
Operating Temperature	Тор	-40 To +100	°C	
Storage Temperature	Tstg	-40 To +115	°C	
DC Forward Current[1]	lF	30	mA	
Peak Forward Current [2]	Іғм	150	mA	
Electrostatic Discharge Threshold (HBM)	3000	V		
Thermal Resistance (Junction/ambient) [1]	Rth j-a	460	°C/W	

Notes:

1. Rth(j-a) Results from mounting on PC board FR4 (pad size≥16 mm² per pad),

2. 1/10 Duty Cycle, 0.1ms Pulse Width.

Electrical / Optical Characteristics at Ta=25°C

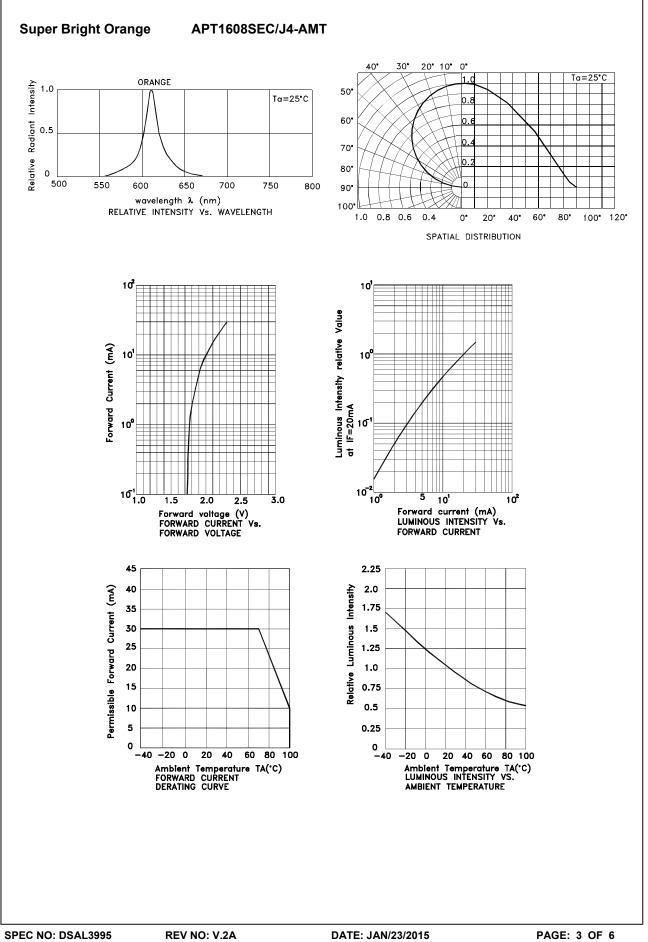
Parameter	Symbol	Value	Unit	
Wavelength at peak emission IF=20mA [Typ.]	λ peak	611	nm	
Dominant Wavelength IF=20mA [Min.]	λ dom [1]	598	nm	
Dominant Wavelength IF=20mA [Max.]	λ dom [1]	612	nm	
Spectral bandwidth at 50% Φ REL MAX $$ IF=20mA $$ [Typ.]	Δλ	17	nm	
Forward Voltage IF=20mA [Typ.]) (= [O]	2.2	V	
Forward Voltage IF=20mA [Max.]	VF [2]	2.8		
Reverse Current (VR = 5V) [Max.]	lr	10	uA	
Temperature coefficient of λ peak IF=20mA, -10 $^\circ$ C \leq T \leq 100 $^\circ$ C [Typ.]	TC λ peak	0.12	nm/° C	
Temperature coefficient of λ dom IF=20mA, -10 $^\circ$ C ≤ T≤100 $^\circ$ C [Typ.]	TC λ dom	0.08	nm/° C	
Temperature coefficient of VF IF=20mA, -10 $^{\circ}$ C \leq T \leq 100 $^{\circ}$ C [Typ.]	TCv	-1.8	mV/° C	

Notes:

1.The dominant Wavelength (λ d) above is the setup value of the sorting machine. (Tolerance λ d : ±1nm.) 2.Forward Voltage: +/-0.1V. 3.Wavelength value is traceable to the CIE127-2007 compliant national standards.

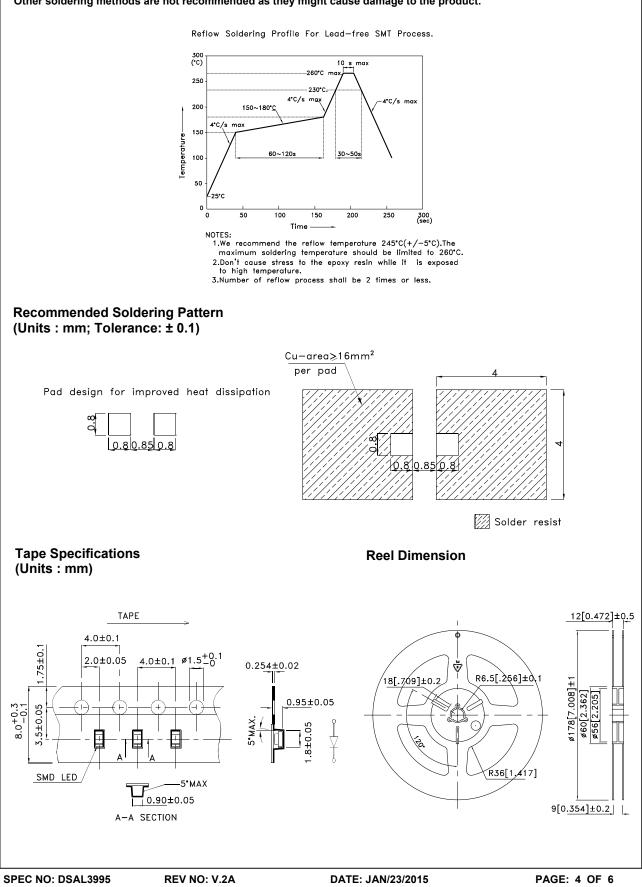
4. Excess driving current and/or operating temperature higher than recommended conditions may result in severe light degradation or premature failure.

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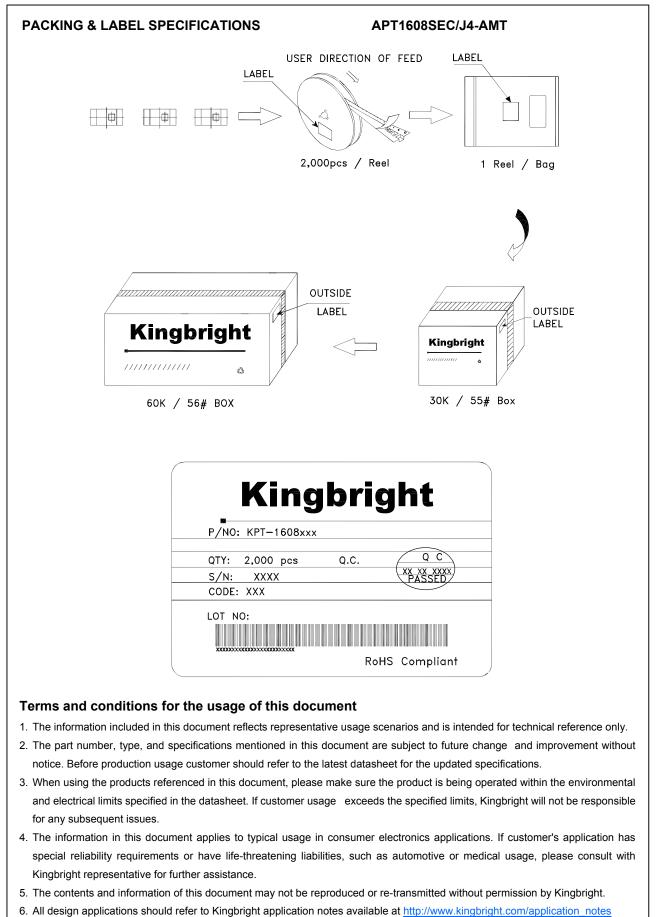
Reflow soldering is recommended and the soldering profile is shown below. Other soldering methods are not recommended as they might cause damage to the product.



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Reliability Test Items And Conditions

The reliability of products shall be satisfied with items listed below

Lot Tolerance Percent Defective (LTPD): 10%

No.	Test Item	Standards	Test Condition	Test Times / Cycles	Number of Damaged
1	Continuous operating test	-	Ta =25°C ,IF = maximum rated current*	1,000 h	0 / 22
2	High Temp. operating test	EIAJ ED- 4701/100(101)	Ta = 100°C IF = derated current at 100°C	1,000 h	0 / 22
3	Low Temp. operating test	-	Ta = -40°C, IF = maximum rated current*	1,000 h	0 / 22
4	High temp. storage test	EIAJ ED- 4701/100(201)	Ta = maximum rated storage temperature	1,000 h	0 / 22
5	Low temp. storage test	EIAJ ED- 4701/100(202)	Ta = -40°C	1,000 h	0 / 22
6	High tomp X. humidity storage test	EIAJ ED- 4701/100(103)	Ta = 60°C, RH = 90%	1,000 h	0 / 22
7	High temp. & humidity operating test	EIAJ ED- 4701/100(102)	Ta = 60°C, RH = 90% IF = derated current at 60°C	1,000 h	0 / 22
8	Soldering reliability test	EIAJ ED- 4701/100(301)	Moisture soak : 30°C,70% RH, 72h Preheat : 150~180°C(120s max.) Soldering temp : 260°C(10s)	2 times	0 / 18
9	Thermal shock operating test	-	Ta = -40°C(15min) ~ 100°C(15min) IF = derated current at 100°C	1,000 cycles	0 / 22
10	Thermal shock test	-	Ta = -40°C(15min) ~ 100°C(15min)	1,000 cycles	0 / 22
11	Electric Static Discharge (ESD)	EIAJ ED- 4701/100(304)	C = 100pF , R2 = 1.5KΩ V = 3000V	Once each Polarity	0 / 22
12	Vibration test	-	a = 196m/s² , f = 100~2KHz , t = 48min for all xyz axes	4 times	0 / 22

* : Refer to forward current vs. derating curve diagram

Failure Criteria

Items	Symbols	Conditions	Failure Criteria
luminous Intensity	lv	IF = 20mA	Testing Min. Value <spec.min.value 0.5<="" td="" x=""></spec.min.value>
Forward Voltage	VF	IF = 20mA	Testing Max. Value ≥Spec.Max.Value x 1.2
Reverse Current	lr	VR = Maximum Rated Reverse Voltage	Testing Max. Value ≥Spec.Max.Value x 2.5
High temp. storage test	-	-	Occurrence of notable decoloration, deformation and cracking